Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/051,367	CRAPO ET AL.
Examiner	Art Unit
Shengjun Wang	1617

SEARCHED				
Class	Subclass	Date	Examiner	
514	183-185	2/14/2006	sw	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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